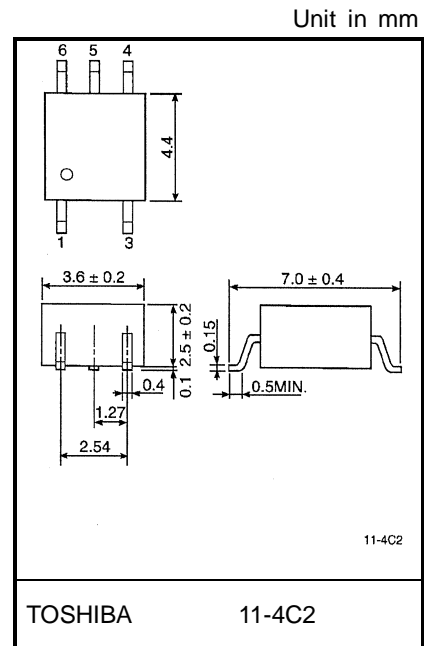


TLP116

PDP(Plasma Display Panel)
 High Speed Interface
 FA(Factory Automation)

The Toshiba TLP116 consists of a GaAlAs light-emitting diode and an integrated high-gain, high-speed photodetector.

- Inverter logic (totempole output)
- Package type : MFSOP6
- Guaranteed performance over temperature : -40~100°C
- Power supply voltage : 4.5~5.5V
- Input thresholds current : $I_{FHL}=5\text{mA}(\text{Max.})$
- Propagation delay time (tpHL/tpLH) : 60ns(Max.)
- Switching speed : 20MBd(TYP.)
- Common mode transient immunity : 10kV/us
- Isolation voltage : 3750Vrms

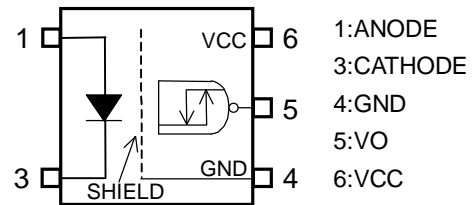


Weight: 0.09 g(Typ.)

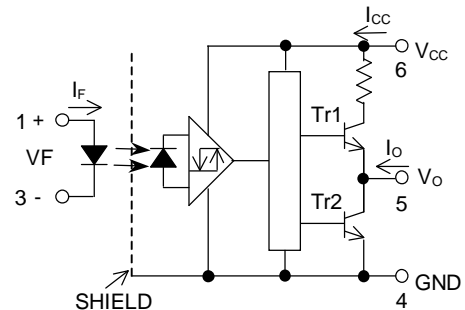
Truth Table

Input	LED	Tr1	Tr2	Output
H	ON	OFF	ON	L
L	OFF	ON	OFF	H

Pin Configuration (Top View)



Schematic



0.1uF bypass capacitor must be connected between pins 6 and 4

Maximum Ratings (Ta=25°C)

Characteristic		Symbol	Rating	Unit
LED	Forward Current	I_F	20	mA
	Forward Current De-rating (Ta≥85°C)	$\Delta I_F/\Delta T_a$	-0.5	mA/°C
	Peak Transient Forward Current (Note1)	I_{FPT}	1	A
	Reverse Voltage	V_R	5	V
DETECTOR	Output Current	I_O	10	mA
	Output Voltage	V_O	6	V
	Supply Voltage	V_{CC}	6	V
	Output Power Dissipation	P_O	40	mW
Operating Temperature Range		T_{opr}	-40~100	°C
Storage Temperature Range		T_{stg}	-55~125	°C
Lead Solder Temperature(10s)		T_{sol}	260	°C
Isolation Voltage (AC, 1min., R.H.≤60%, Ta=25(C) (Note2)		BVs	3750	Vrms

Recommended Operating Conditions

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Input Current , ON	$I_{F(ON)}$	8	—	18	mA
Input Voltage , OFF	$V_{F(OFF)}$	0	—	0.8	V
Supply Voltage (Note3)	V_{CC}	4.5	5.0	5.5	V
Operating Temperature	T_{opr}	-40	—	100	°C

Correlation Between Input Current , Switching Speed and Drive Circuit (reference information).

Input Current (IF)	Test Circuit	Typical Switching Speed
12mA	1 (Page 4)	21 – 23 MBd
8mA	1 (Page 4)	18 – 20 MBd
8mA	2 (Page 4, With Speed up capacitor)	23 – 27 MBd

Note1 : Pulse width $PW \leq 10\mu s, 500pps$.

Note2 : This device is regarded as a two terminal device : pins 1 and 3 are shorted together, as are pins 4,5 and 6.

Note3 : The detector of this product requires a power supply voltage (VCC) of 4.5 V or higher for stable operation.

If the VCC is lower than this value, an ICC may increase, or an output may be unstable.

Be sure to use the product after checking the supply current, and the operation of a power-on/-off.

Electrical Characteristics

(Unless otherwise specified, Ta=-40 to 100°C, VCC=4.5~5.5V^{Note 3})

Characteristic	Symbol	Test Circuit	Conditions	Min.	Typ.	Max.	Unit
Input Forward Voltage	V _F	—	I _F =10mA, Ta=25°C	—	1.3	1.5	V
Temperature Coefficient of Forward Voltage	ΔV _F /ΔTa	—	I _F =10mA	—	-2.0	—	mV/°C
Input Reverse Current	I _R	—	V _R =5V, Ta=25°C	—	—	10	μA
Input Capacitance	C _T	—	V=0, f=1MHz, Ta=25°C	—	70	—	pF
Logic Low Output Voltage	V _{OL}	1	I _{OL} =1.6mA, I _F =12mA, V _{CC} =5V	—	—	0.4	V
Logic High Output Voltage	V _{OH}	2	I _{OH} =-0.02mA, V _F =1.05V, V _{CC} =5V	4.0	—	—	V
Logic Low Supply Current	I _{CCL}	3	I _F =12mA	—	—	5.0	mA
Logic High Supply Current	I _{CCH}	4	V _F =0V	—	—	5.0	mA
Input Current Logic Low Output	I _{FHL}	—	I _O =1.6mA, V _O <0.4V	—	—	5	mA
Input Voltage Logic High Output	V _{FLH}	—	I _O =-0.02mA, V _O >4.0V	0.8	—	—	V

*All typical values are at Ta=25°C, VCC=5V, I_F=(ON)=12mA unless otherwise specified

Isolation Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Capacitance Input to Output	C _S	V = 0, f = 1MHz (Note 2)	—	0.8	—	pF
Isolation Resistance	R _S	R.H. ≤ 60%, V _S = 500V (Note 2)	1×10 ¹²	10 ¹⁴	—	Ω
Isolation Voltage	BV _S	AC, 1 minute	3750	—	—	V _{rms}
		AC, 1 second, in oil	—	10000	—	V _{dc}
		DC, 1 minute, in oil	—	10000	—	

Note 4: A ceramic capacitor(0.1 μF) should be connected from pin 6 to pin 4 to stabilize the operation of the high gain linear amplifier. Failure to provide the bypass may impair the switching property.
The total lead length between capacitor and coupler should not exceed 1 cm.

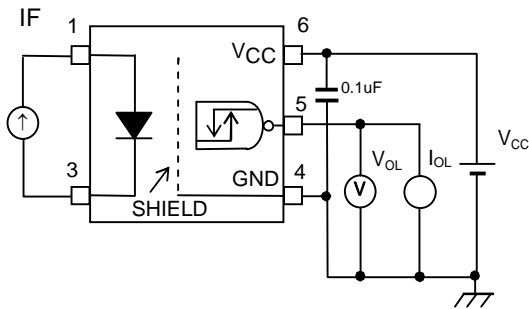
Switching Characteristics
 (Unless otherwise specified, $T_a = -40$ to 100°C , $V_{CC} = 4.5 \sim 5.5\text{V}$)

Characteristic	Symbol	Test Circuit	Conditions	Min.	Typ.	Max.	Unit
Propagation Delay Time to Logic High output	tpHL	5	$I_F = 0$ 12mA	—	—	60	ns
Propagation Delay Time to Logic Low output	tpLH		$I_F = 12$ 0mA				
Propagation Delay Time to Logic High output	tpHL	6	$V_{IN} = 0$ 5V ($I_F = 0$ 8mA)	—	—	60	ns
Propagation Delay Time to Logic Low output	tpLH		$V_{IN} = 5$ 0V ($I_F = 8$ 0mA)				
Switching Time Dispersion between ON and OFF	$ \text{tpHL} - \text{tpLH} $	5	$I_F = 12\text{mA}$, $R_{IN} = 100$, $C_L = 15\text{pF}$ (Note 5)	—	—	30	ns
Output Fall Time(90-10%)	tf		$I_F = 0$ 12mA	—	15	—	ns
Output Rise Time(10-90%)	tr		$I_F = 12$ 0mA	—	15	—	ns
Common Mode Transient Immunity at High Level Output	CM _H	7	$V_{CM} = 1000\text{Vp-p}$, $I_F = 0\text{mA}$, $V_o(\text{Min}) = 4\text{V}$, $T_a = 25^\circ\text{C}$	10000	—	—	V/us
Common Mode Transient Immunity at Low Level Output	CM _L		$V_{CM} = 1000\text{Vp-p}$, $I_F = 12\text{mA}$, $V_o(\text{Max}) = 0.4\text{V}$, $T_a = 25^\circ\text{C}$	-10000	—	—	V/us

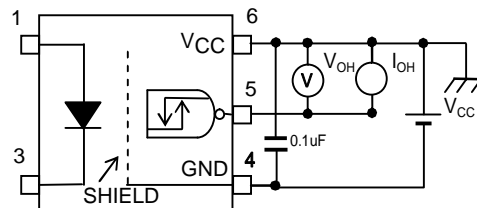
*All typical values are at $T_a = 25^\circ\text{C}$

Note 5 : C_L is approximately 15pF which includes probe and Jig/stray wiring capacitance.

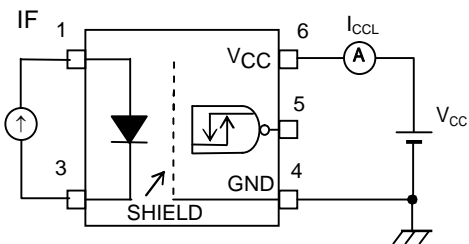
TEST CIRCUIT 1 : V_{OL}



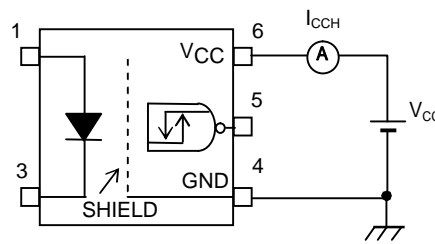
TEST CIRCUIT 2 : V_{OH}



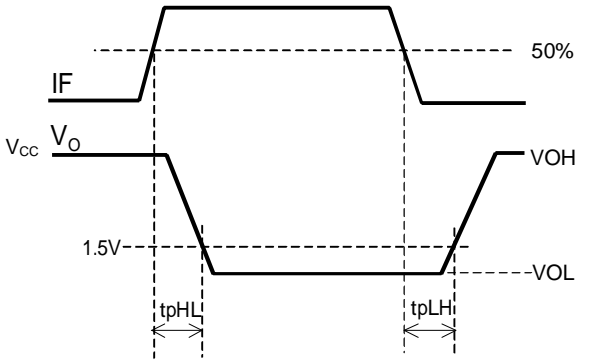
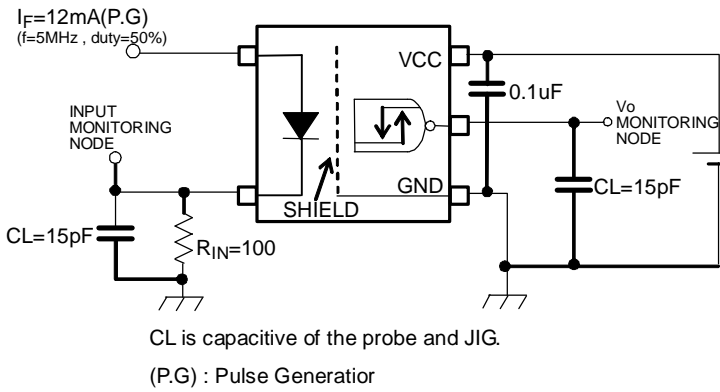
TEST CIRCUIT 3 : I_{CCL}



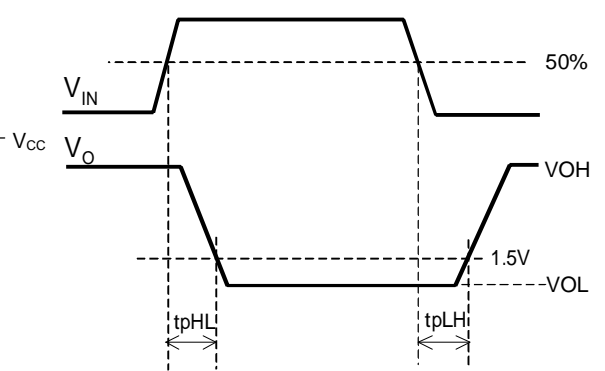
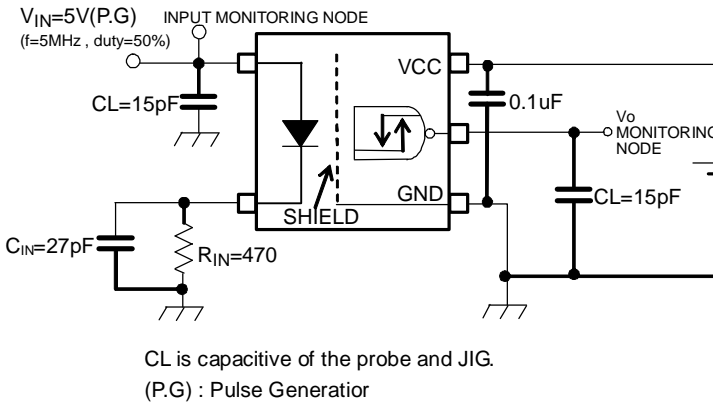
TEST CIRCUIT 4 : I_{CCH}



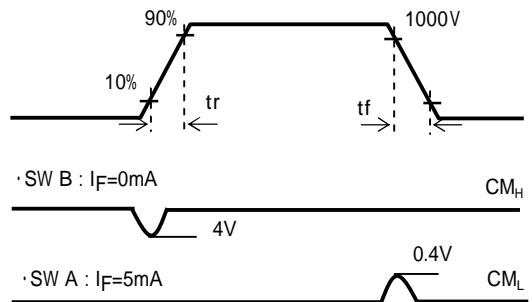
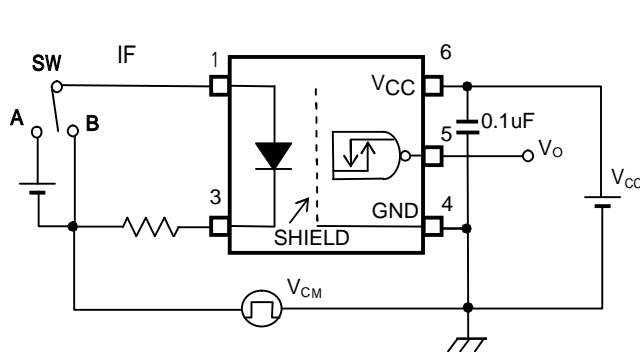
TEST CIRCUIT 5 : tpHL , tpLH



TEST CIRCUIT 6 : tpHL , tpLH



TEST CIRCUIT 7 : Common-Mode Transient Immunity Test Circuit



$$CM_H = \frac{800(V)}{t_f(\mu s)} \quad CM_L = \frac{800(V)}{t_r(\mu s)}$$

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